

<b>Notice of References Cited</b>	Application/Control No. 10/530,307		Applicant(s)/Patent Under Reexamination BHAT ET AL.	
	Examiner SIU M. LEE		Art Unit 2611	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,831,705	12-2004	Yamamoto, Kazuhiko	348/731
*	B	US-4,654,884	03-1987	Sakai et al.	455/183.2
*	C	US-7,061,993	06-2006	Wieck, Christopher Peter	375/316
*	D	US-5,722,061	02-1998	Hutchison et al.	455/245.1
*	E	US-6,009,129	12-1999	Kenney et al.	375/346
*	F	US-5,758,271	05-1998	Rich et al.	455/234.1
*	G	US-5,513,387	04-1996	Saito et al.	455/243.1
*	H	US-2001/0029172	10-2001	Lee et al.	455/234.1
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	X				

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